

## Emergence of WBG Based Power Electronics and System Level Needs / Opportunities for Advances in Passives, Packaging, and Peripherals with Emphasis on HF Magnetics

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Electrochemical and Magnetic Materials Team

Functional Materials Development Division

NETL Office of Research and Development

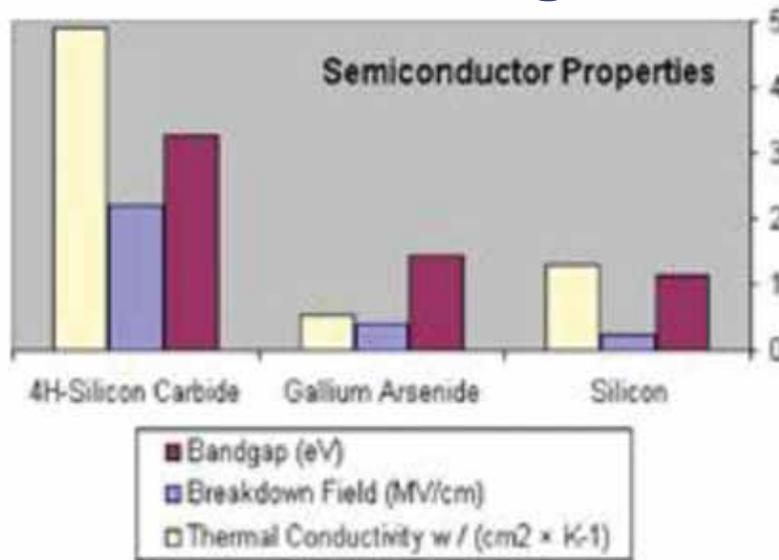


# Overview of Presentation

- Historic Thrust in Active Components for WBG-Based Power Electronics
  - Promise of WBG-Based Semiconductors Relative to Si
  - Technical / Cost Progress Driven By Sustained Government Investment
  - Commercial and Near-Commercial Devices Reaching Maturity
- Systems Level Needs for WBG-Based Power Electronics
  - Systems Levels Design Issues (Harmonics, EMI, Parasitics)
  - Thermal Management
  - Advances in Passive Components (Packaging, Capacitors, Magnetics)
- Needs and Opportunities for Research in HF Magnetics
  - Existing and Emerging Materials for HF Inductors / Transformers
  - Advanced Inductor / Transformer Fabrication and Design
  - Novel Power Conversion Topologies Leveraging HF Transformers
- Summary and Conclusion

# **Historic Thrust in Active Components for Wide Bandgap Semiconductor Based Devices**

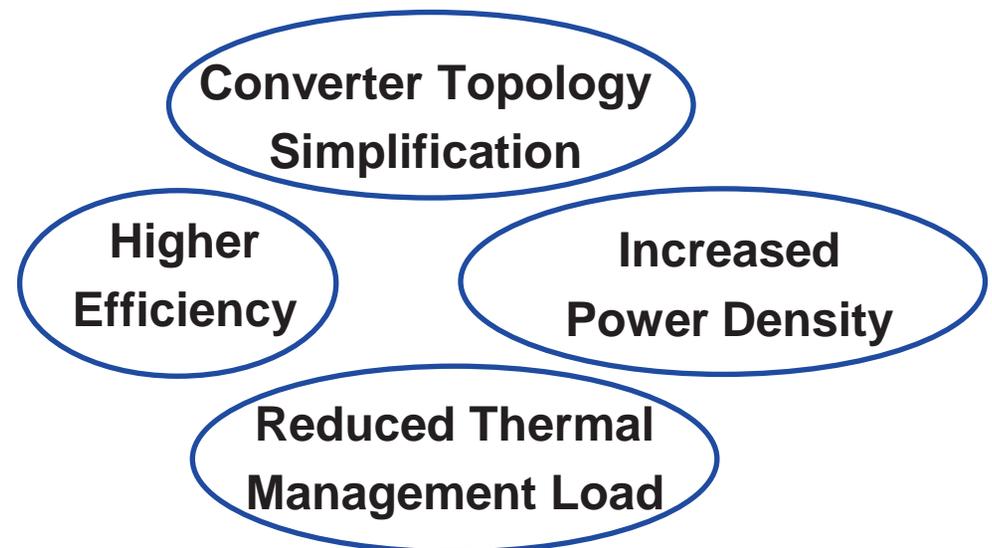
# Technical Advantages of WBG Semiconductor Devices



| Device      | BV (kV)   | 500 Hz<br>5 kV<br>$P_{sw,sp}$ (W/cm <sup>2</sup> ) | 5 kHz<br>5 kV<br>$P_{sw,sp}$ (W/cm <sup>2</sup> ) | 20 kHz<br>5 kV<br>$P_{sw,sp}$ (W/cm <sup>2</sup> ) | 33 A/cm <sup>2</sup><br>50% Duty<br>100°C<br>$P_{cond,sp}$ (W/cm <sup>2</sup> ) |
|-------------|-----------|--|---|--|---|
| SiC DMOSFET | 10        | 4  | 40  | 160  | 100   |
| SiC n-IGBT  | 12        | 6.5  | 65  | 260  | 66  |
| Si IGBT     | 2x<br>6.5 | 72.5   | 725   | 2900   | 182   |

## New Materials Enable Revolutionary Device / System Level Advances!

- Higher Reverse Voltages
- Higher Switching Frequencies
- Higher Temperature Operation
- Increased Thermal Conductivity
- Lower On-State Losses



# Sustained Government Investment in WBG-Based Devices

## Example Major WBG Development Programs:

- DARPA WBG High-Power Electronics (HPE)
  - Air Force Office of Scientific Research
- Office of Naval Research Advanced Electrical Power Systems (AEPS)
  - Army Research Laboratory
  - National Aeronautics and Space Administration (NASA)
- NIST Semiconductor Electronics Division
- National Science Foundation (VA Tech CPES)

### Most Recently within DOE:

- DOE ARPA-E Switches (2014)
- DOE EERE AMO PowerAmerica (2014)

**Motivated by the Promise and Potential for WBG-Based Devices, Semiconductor Materials and Associated Devices Have Seen Sustained and Significant Government Funding Over Time.**

### Major Cost Reductions Result from 3 Factors

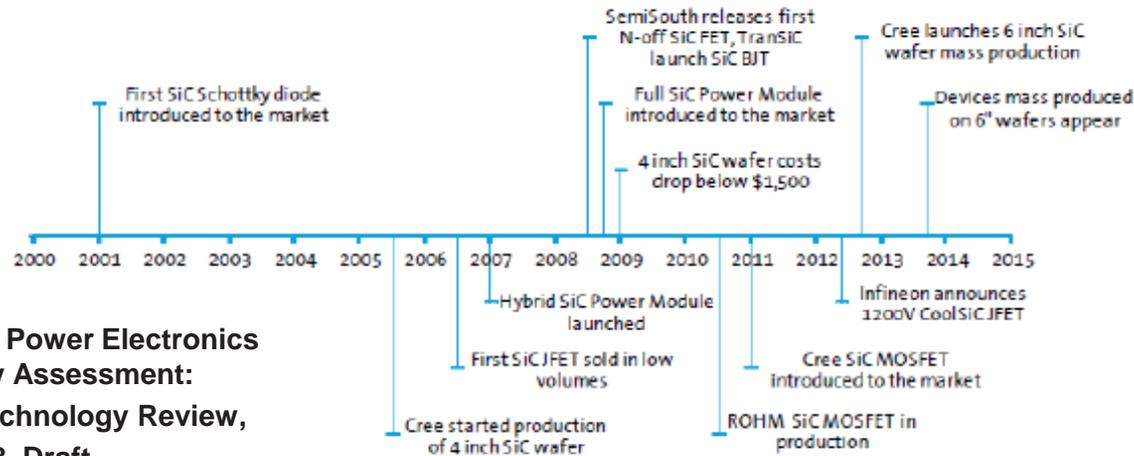
- Higher Quality SiC Material
- Larger Production Volumes
- SiC Wafer Diameter Increased From 3" to 100"



Figure 3. Decline of device cost for Cree SiC products over time (Hull, 2013)

From: Wide Bandgap Power Electronics  
Technology Assessment:  
DOE Quadrennial Technology Review,  
Chapter 8, Draft

# SiC-Based Commercial and Near-Commercial Devices



From: Wide Bandgap Power Electronics Technology Assessment: DOE Quadrennial Technology Review, Chapter 8, Draft

Figure 2. Milestones in SiC power electronics development (Eden, 2013)

Table 1. Distribution of 2010 silicon carbide power electronics device revenues by company and fab location (Yole Développement, 2012).

| Company           | 2010 SiC Power Electronics Revenue (Million \$) | Headquarter | Fab location                       |
|-------------------|---|-------------|------------------------------------|
| Infineon          | \$27.1  | Germany     | Villach, Austria                   |
| Cree Technologies | \$19.7  | U.S.A       | Durham, NC, U.S.A                  |
| STMicro           | \$1.6   | Switzerland | Catania, Italy                     |
| Rohm              | \$1.1   | Japan       | Fukuoka, Japan and Miyazaki, Japan |
| All others        | \$3.7   |             |                                    |
| Total             | \$53.2  |             |                                    |

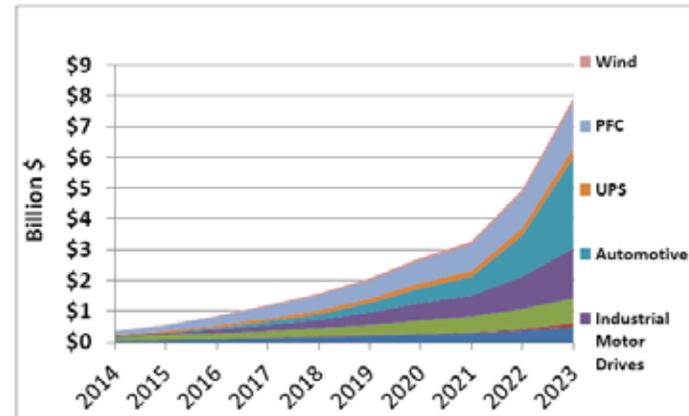


Figure 1. Projected sales for WBG power electronic devices (Eden, 2013)

**SiC-Based Switching Devices Have Been Commercialized with More Expected on the Horizon. Market Projections for WBG-Based Power Electronics are Highly Optimistic Suggesting Significant Growth Potential.**

# System Level Needs for WBG-Based Power Electronics

# Future Promise of Grid-Scale WBG-Based Power Electronics

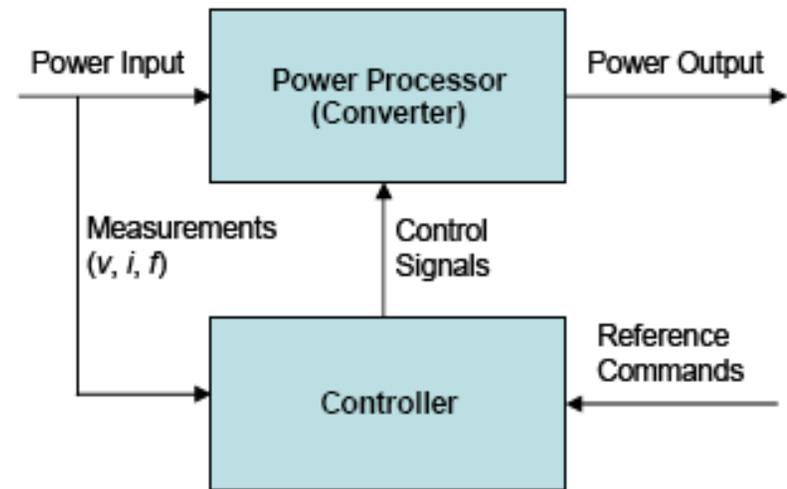


Fig. 1.1. Block diagram of a power electronic system.

POWER ELECTRONICS FOR  
DISTRIBUTED ENERGY SYSTEMS AND  
TRANSMISSION AND DISTRIBUTION  
APPLICATIONS

Publication Date: December 2005

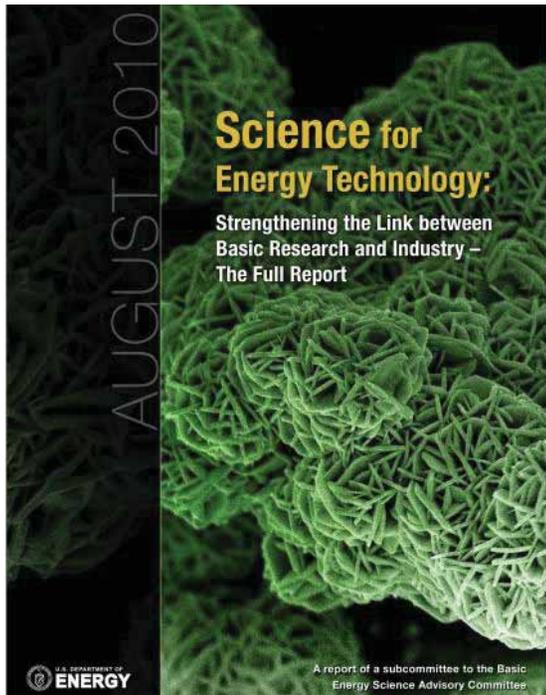
ORNL/TM-2005/230

**WBG-Based Power Electronics Show Significant Potential for Emerging T&D / Grid Related Applications Including:**

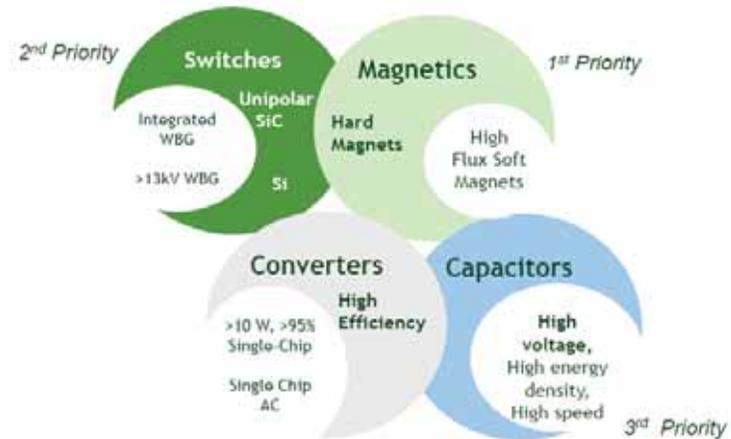
- **Distributed Energy Grid Integration (PV, Fuel Cells, ES, EV, Microturbine)**
- **Power Flow Controllers for T&D Applications (FACTS, HVDC)**

**WBG Switching Devices ≠ WBG-Based Power Electronic Systems!**

# Needs for Advanced Power Electronic Materials

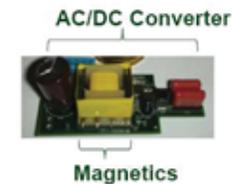


**Basic Energy Sciences  
2010 Report:  
Emphasis on Grid Technologies  
Key Research Priority:  
Power Electronic Materials**



Overwhelmingly the workshop attendees cited magnetics (Inductors & transformers) as the primary limit to cost, size, weight, manufacturing.

“For forty years the inductors haven’t changed.”



arpa-e

**ARPA-E 2010 Workshop:  
Soft Magnetic Materials for Inductors  
Highest Priority for Their Program Due  
to Historic Lack of Federal Investment.  
[www.arpa-e.energy.gov](http://www.arpa-e.energy.gov)**

**NATIONAL ENERGY TECHNOLOGY LABORATORY**

# Needs for Advanced Power Electronic Materials

**TMS2015**  
**144<sup>th</sup> Annual Meeting & Exhibition**

**March 15-19, 2015 • Walt Disney World  
Orlando, Florida, USA**

**Organized by:**

Paul Ohodnicki, National Energy Technology Laboratory (USA)  
Michael Lanagan, Penn State University (USA)  
Michael McHenry, Carnegie Mellon University (USA)  
Rachael Myers-Ward, Naval Research Laboratory (USA)  
Clive Randall, Penn State University (USA)  
Matthew Willard, Case Western Reserve University (USA)

**Advanced Materials for Power Electronics, Power Conditioning, and Power Conversion III**

Independent of the means by which electrical power is generated (conventional fossil, advanced fossil, nuclear, solar, wind, etc.), power conditioning and conversion is required to transform power into an appropriate form for efficient and cost-effective integration into the grid. By 2030, it is also projected that 80% of all electricity will flow through power electronics. Advanced materials including soft magnetic materials, semiconductors, and dielectric materials for capacitors are crucial for enabling the next generation of advanced power electronics technologies.

These technical communities have historically worked independent of one another, and materials development efforts have often been carried out in the absence of frequent and meaningful interactions with the power electronics community. The proposed symposium aims to bridge these historical gaps through a number of technical symposia devoted to relevant materials systems including soft magnets, dielectric materials for capacitors, and semiconductor materials. The primary focus of the proposed symposium will be in the area of advanced materials for power electronics and power conditioning systems. A range of invited and contributed talks will be presented by the top materials scientists in each field. To supplement the traditional technical sessions, a selected group of technical experts from the power electronics community will also be invited to present and to engage the materials community. These invited talks are intended to promote interactions between the materials and power electronics communities, to educate the materials community about critical materials needs, and to educate the power electronics community about state-of-the-art material developments.

**We Have Recently Organized a New Symposium at TMS Annual 2012-2015 Meetings to Help Address these Emerging Needs. Soft Magnetic Materials, Semiconductors, Capacitors, and Packaging Materials were All Included in the Programming**

<http://www.tms.org/meetings/annual-15/AM15home.aspx>

# Systems-Level Challenges to Fully Leverage WBG Devices

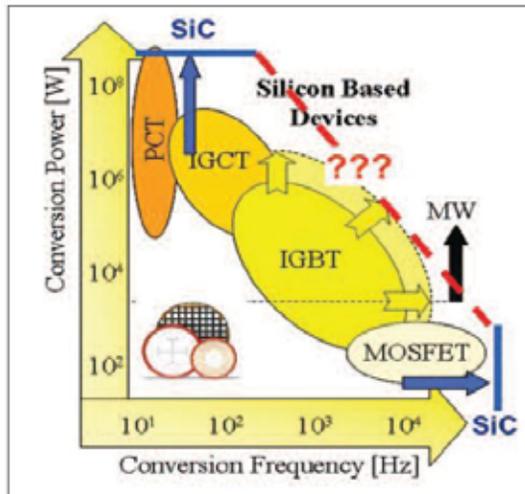


Figure 1: Power semiconductors and their power and frequency range in MW PE applications

## Technical Challenges at Converter / System Level

- **Increasing Frequencies of High-Voltage / Power Devices:**
  - Parasitic Inductances / Capacitances
  - EMI Effects Due to Stray Fields / Harmonics
  - Increased Losses of Inductors / Magnetics
- **Reduced Volume / Increased Power Density**
  - Higher Temperature / Frequency of Passives
  - Thermal Management
  - Electrical Contacts, Bonding, and Packaging

“Wide Bandgap Power Devices in Megawatt Applications”

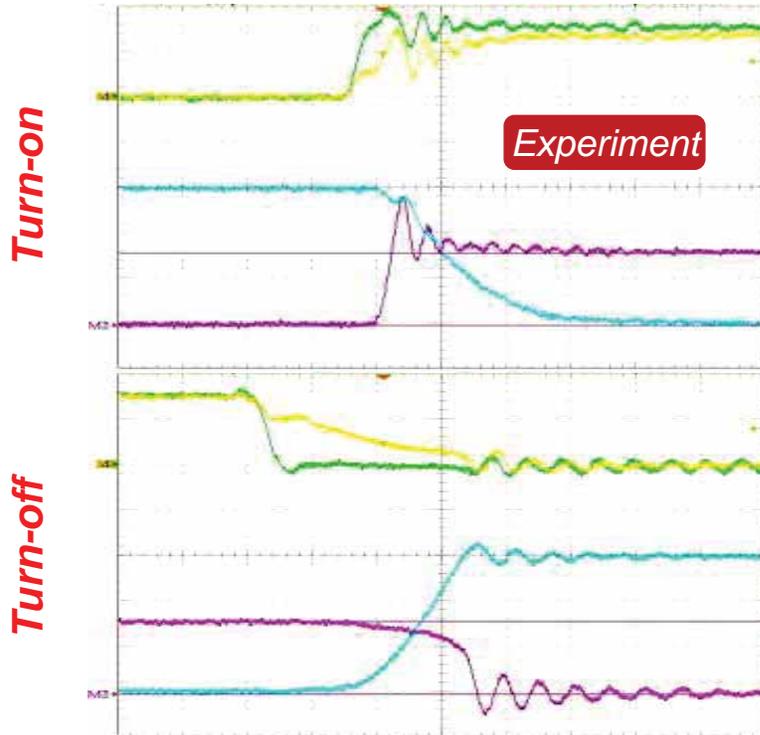
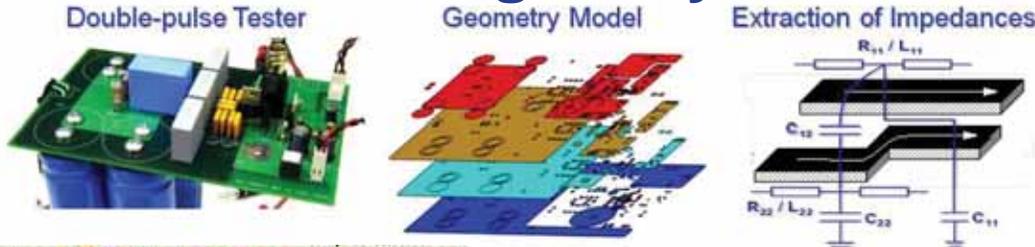
[www.power-mag.com](http://www.power-mag.com)

Issue 4, 2012,

Power Electronics Europe

**Systems-Level Issues, Passives, and Peripherals Have Not Experienced the Same Sustained R&D Funding / Focus as WBG Switching Devices. Major Opportunities and Needs Exist for New Materials Innovations!**

# Systems-Level Design, Layout, and Modeling

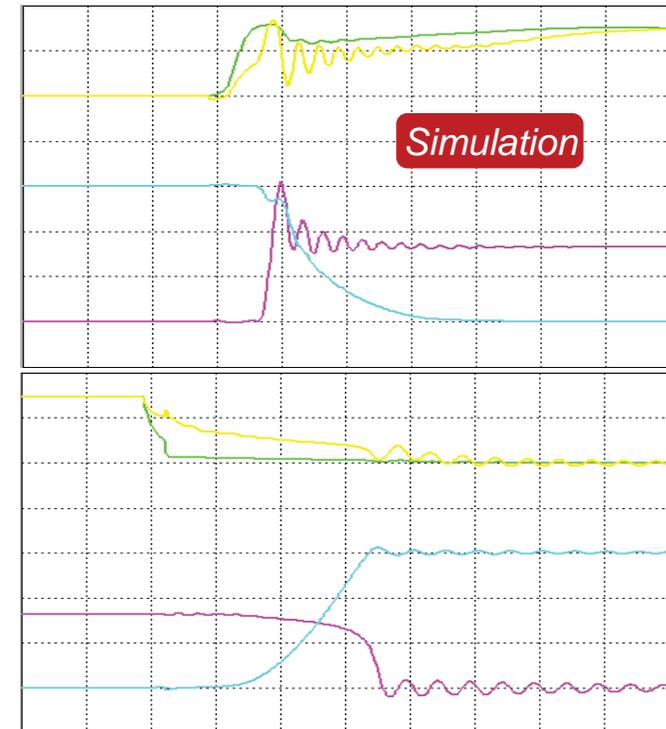


$V_{drive}$   
(10 V/div)

$V_{gs}$   
(10 V/div)

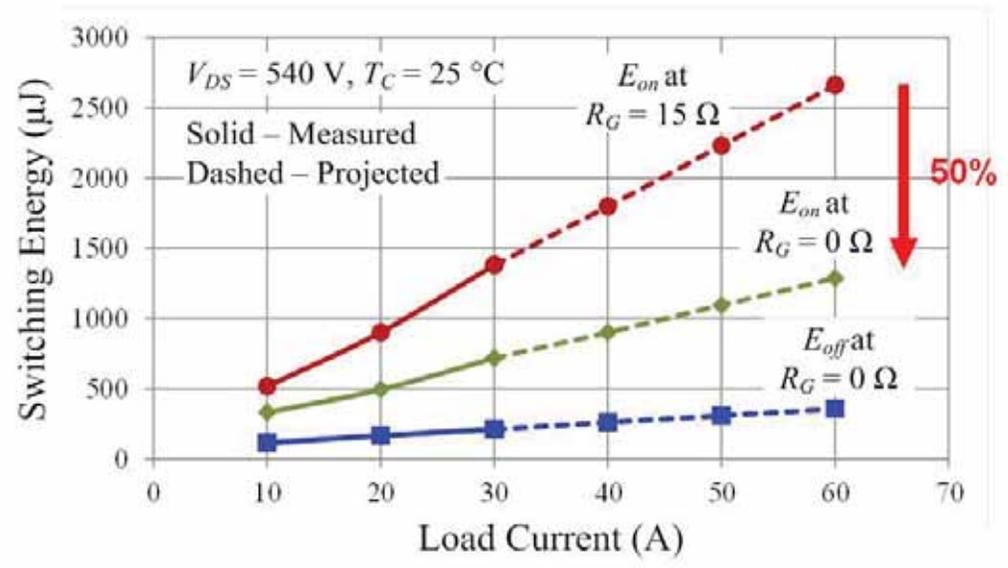
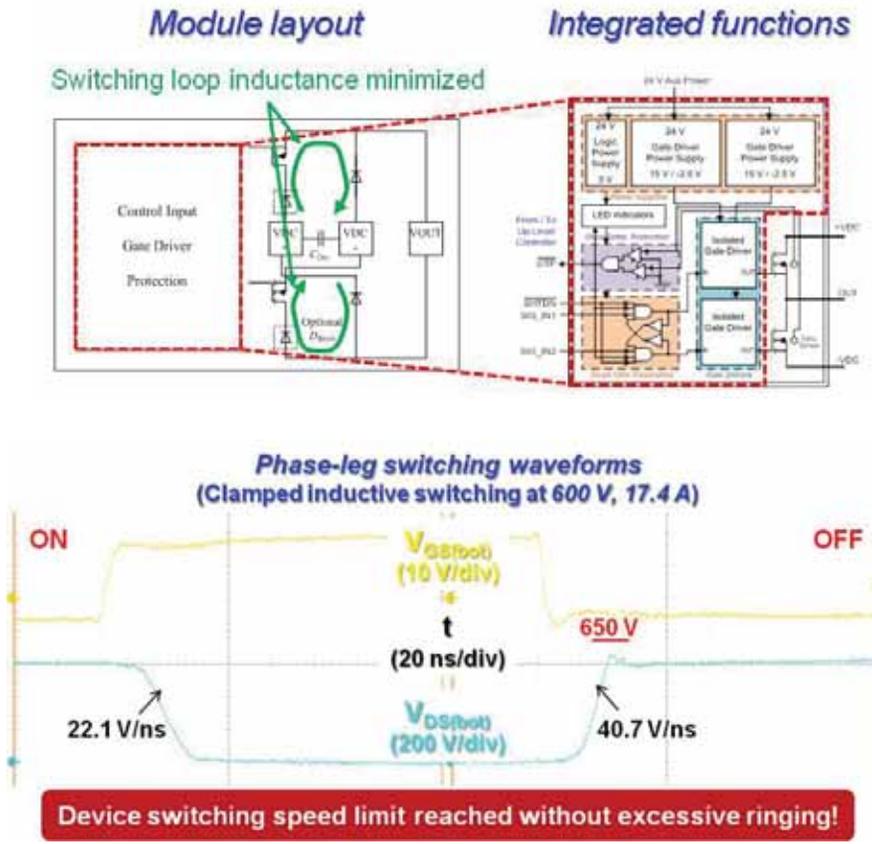
$V_{ds}$   
(200 V/div)

$I_d$   
(5 A/div)



**Parasitic Inductances and Capacitances Associated with Circuit Design Can Cause Oscillatory Behavior and “Ringing” During WBG-Switching. Advanced Component Design and Layout Can Address and Mitigate.**

# Systems-Level Design, Layout, and Modeling



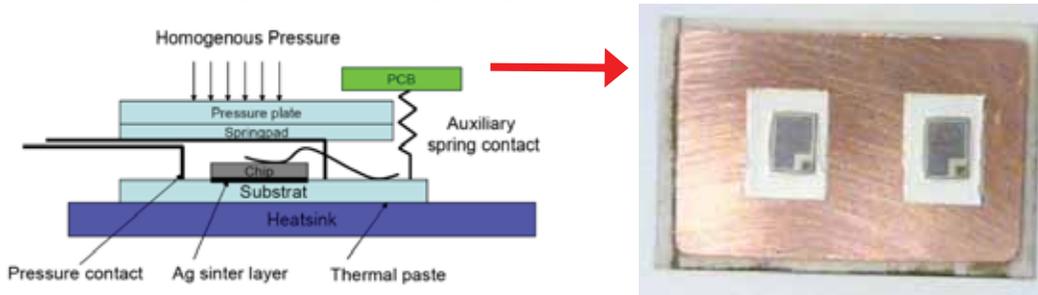
Smaller switching energy can be achieved without compromising to the parasitic ringing.

For Example, Through Advanced WBG Converter Module Layout Switching Loop Inductance Can Be Minimized.

Reduced Ringing and Switching Energies are Achieved as a Result!

# Systems-Level Packaging and Thermal Management

## Bonding, Packaging, and Thermal Management

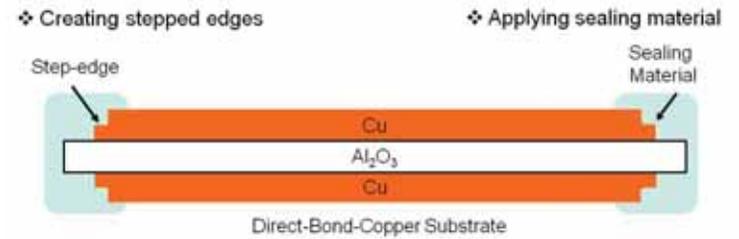


*Ag sintering based die-attachment*

*Sintering of nanoAg paste to Reduce P. / Temp. Requirement.*

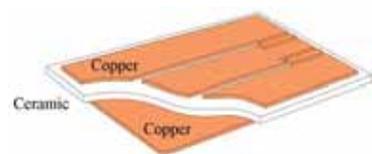
## Sealing / Packaging

**Now ~1200 Cycles to Failure!**



**< 20 cycles**

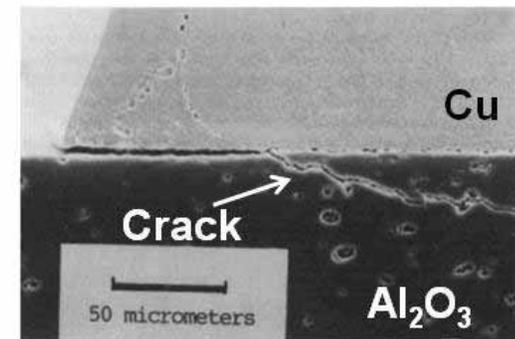
**Repeated Cycling from -50 to 200°C, Direct Bond Copper Substrate Fails**



**Before temperature cycling**



**After temperature cycling**



**Materials Innovations Can Improve Bonding Strength at Elevated Temps., Performance, Processability, and Thermal Management.**

**Packaging, Substrates, Bonding Impacts on Parasitics Need Considered!**

# Advanced Passives for WBG-Based Power Electronics

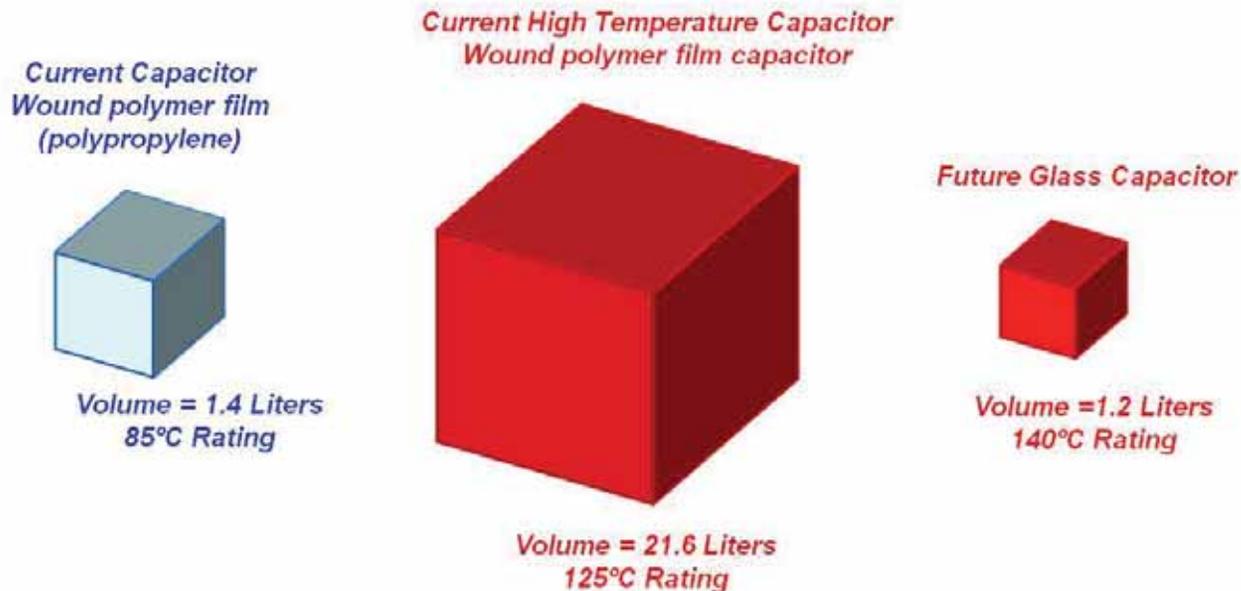
$$\text{Energy} = \frac{1}{2} C V^2 \quad \text{Joules}$$

*Capacitance* (points to C)  
*Voltage* (points to V)

$$\text{Energy density} = \frac{1}{2} \epsilon_0 \epsilon'_r \vec{E}^2 \quad \frac{\text{Joules}}{\text{cm}^3}$$

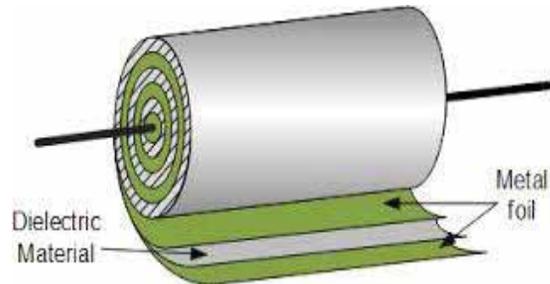
*Permittivity* (points to  $\epsilon_0 \epsilon'_r$ )  
*Electric Field* (points to  $\vec{E}$ )

Volume of 1000  $\mu\text{F}$  600V capacitors in a Power Converter



For Capacitors, Higher Operational Temperatures While Retaining Sufficient Energy Densities Requires Advances in Capacitor Materials. Glasses are Potential Materials of Interest for Higher Temperatures.

# Advanced Passives for WBG-Based Power Electronics



**Typical Polymer Film Capacitor  
Replace with Other Dielectrics?**



Coiled glass capacitor fabricated at Penn State by spraying Ag ink on the glass ribbon and then winding the ribbon around a mullite mandrel.  
Right side: free standing glass ribbon section  
Left side: fully packaged coiled glass capacitor



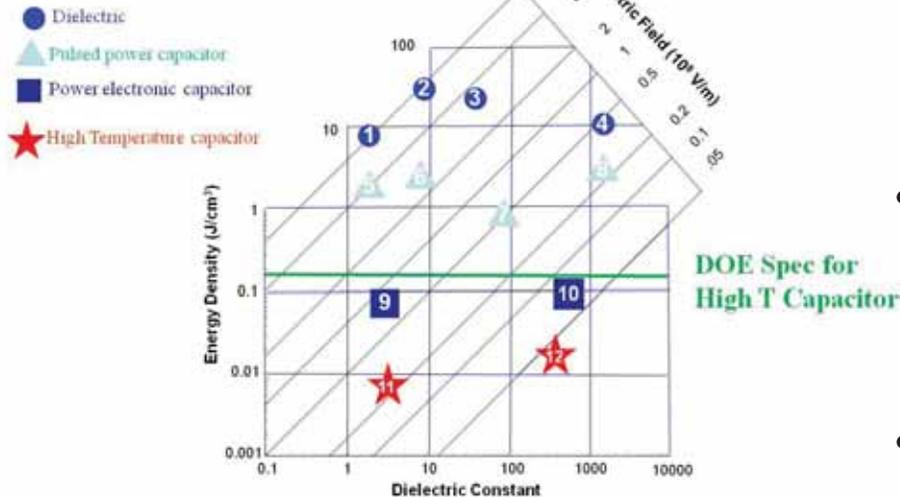
Coiled Capacitor

| Temperature | Frequency | Capacitance, nF | Loss  |
|-------------|-----------|-----------------|-------|
| 50°C        | 1 KHz     | 67.2            | 0.001 |
|             | 10 KHz    | 67.1            | 0.002 |
| 100°C       | 1 KHz     | 67.6            | 0.004 |
|             | 10 KHz    | 67.4            | 0.003 |
| 150°C       | 1 KHz     | 68.2            | 0.005 |
|             | 10 KHz    | 67.9            | 0.003 |

**Examples of High Temperature Capacitors Fabricated Using Commercially Available Glass as the Dielectric Materials Showing Good Performance.**

# Advanced Passives for WBG-Based Power Electronics

## Energy Comparison for Materials

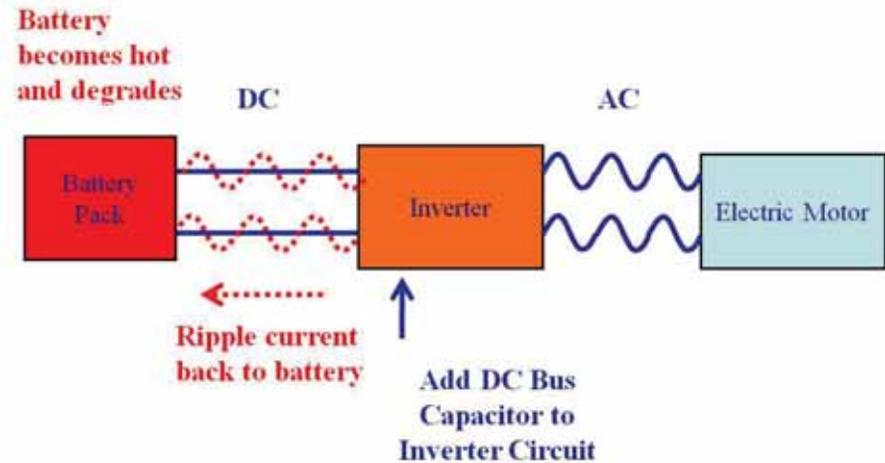


(1) Polypropylene, (2) Alkali-free Barium Boroaluminosilicate Glass, (3) Fluoropolymer, (4) PZT Ceramics, (5) Polypropylene Capacitor (6) High-k Polymer Capacitor, (7) NPO MLCC, (8) X7R based MLCC, (9) Polypropylene film capacitor, (10) X7R MLCC, (11) High Temperature, 125°C, Polymer Capacitor, (12) High Temperature, 200°C, MLCC.

- **Multilayer Ceramic Capacitors:**
  - Excellent high temperature performance
  - Smaller than film caps
  - Lack self-healing behavior
- **Polymer Film Capacitors**
  - Excellent performance and size
  - Self-healing capability
  - Low ripple current at high temperature
- **Glass Capacitors**
  - High temperature performance, self healing

**DC Bus Capacitors are a Key Application for Variable Frequency Drives, Electric Motors, etc.**

**Relevant Targets for High Temperature and High Performance Capacitors in Various Applications are Illustrated.**



# Advanced Passives for WBG-Based Power Electronics

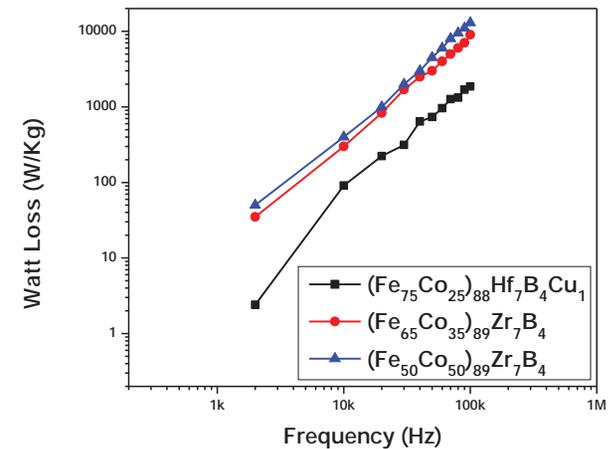
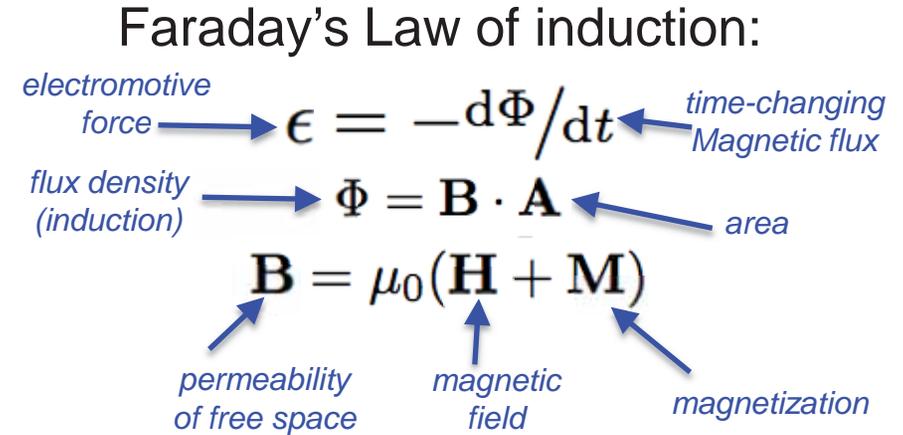
## 60Hz vs 20kHz



330kVA 60Hz Transformer 55" high and 2700Lb



250kVA 20kHz Transformer 16" high and 75Lb



$$P_t = k f^\alpha B^\beta$$

Increased Losses at Elevated Frequency (Eddy Currents)

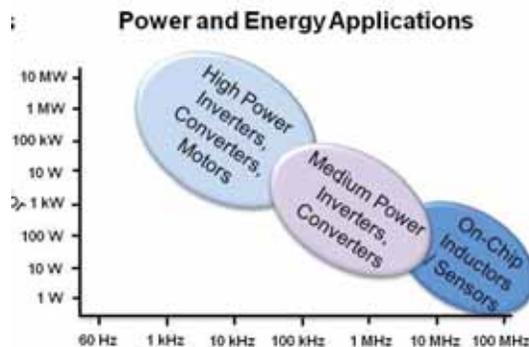
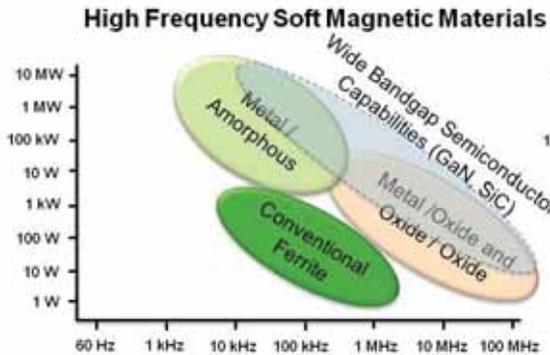
| 15kV Class > 1MVA Transformer Frequency | Fx to 60Hz Ratio | Transformer Core Mass Reduction Factor | Transformer Core Volume Reduction Factor |
|---|------------------|--|--|
| 60Hz                                    | 1                | 1                                      | 1  |
| 400Hz                                   | 7                | 8                                      | 1.4                                      |
| 1kHz                                    | 17               | 10                                     | 1.7                                      |
| 20kHz                                   | 333              | 68                                     | 34                                       |
| 50kHz                                   | 833              | 82                                     | 34                                       |

**High Frequency / High Temperature Magnetics is a Materials Challenge, But Large Volume Reductions are Possible (Inductors, Transformers).**

# Relevant Classes of Soft Magnetic Materials

## Ferrites:

- High Resistivity Limits Eddy Current Losses
- Saturation Induction Limits High Power Application



| Classes of Materials | Relevant Frequency Range | Maximum Saturation Induction (T) | DC permeability | Resistivity ( $\Omega - \text{cm}$ ) | Useful Temperature Range (C) |
|----------------------|--------------------------|----------------------------------|-----------------|--------------------------------------|------------------------------|
| Bulk Metallic Alloys | DC – 1kHz                | 2.5                              | $10^2 - 10^5$   | $0.5 \times 10^{-6}$                 | <500                         |
| Powder Core          | 10 – 500kHz              | 1.6                              | 20 - 500        | 1                                    | <200                         |
| Ferrites             | 10kHz – 100MHz           | 0.5                              | 100 - 5000      | $10^2 - 10^8$                        | <300                         |
| Amorphous Alloys     | DC - 100kHz              | 1.5                              | $10^5$          | $130 \times 10^{-6}$                 | <200                         |
| Nanocomposites       | DC - 100kHz              | 1.9                              | $10^0 - 10^5$   | $110 \times 10^{-6}$                 | <400                         |

## Major Area of Emphasis for NETL and Collaborators

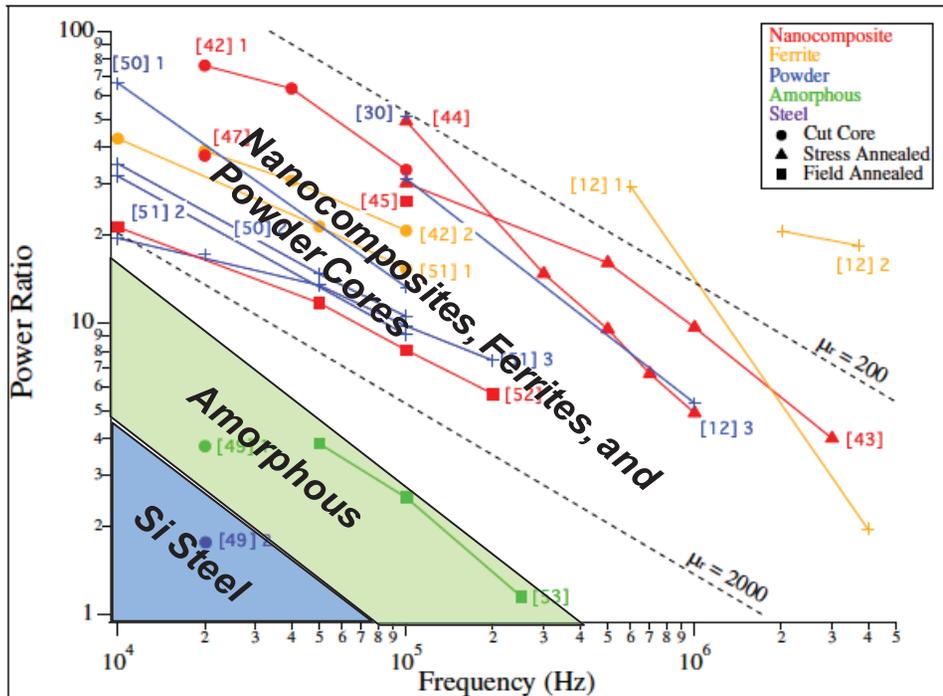
Bulk Metallic Alloys are Too Lossy at kHz Frequencies for WBG Power Electronics, and Powder Cores Introduce EMI and Parasitics (Stray Fields).

**Amorphous and Nanocomposite Magnets Have Ideal Combinations of Saturation Induction and Losses for High Power, HF Applications and Also Higher Efficiency than Many Si-Steels Even For 60Hz Transformers.**

# Soft Magnetic Materials for High Power and Frequency

“Soft Magnetic Materials in High-Frequency, High-Power Conversion Applications”

A. Leary, P. Ohodnicki, and M. McHenry, JOM, Vol. 64 #7 pp. 772-781 (2012).



$$\text{Power Ratio} = \frac{\text{Stored Power}}{\text{Power Loss}} = \frac{\frac{1}{2} B_m H 2f}{1000 k f_{kH z}^\alpha B_m^\beta}$$

$$\text{Stored power } \left( \frac{W}{m^3} \right) = BHf = \frac{B^2}{\mu} f$$

$$\eta = \frac{\text{Stored power} - \text{Power loss}}{\text{Stored power}}$$

| Reference | Author                     | Material   |
|-----------|----------------------------|--|
| [12] 1    | Li et al., 2010            | MnZn Ferrocube 3F51  |
| [12] 2    | Li et al., 2010            | NiZn Ferrocube 4F1   |
| [12] 3    | Li et al., 2010            | Cool Mu  |
| [49] 1    | Rylko et al., 2010         | METGLAS 2605SA1  |
| [49] 2    | Rylko et al., 2010         | JFE 10JNH600   |
| [42] 1    | Fukunaga et al., 1990      | FINEMET FT-1M cut core   |
| [42] 2    | Fukunaga et al., 1990      | Ferrite TDK H3ST cut core  |
| [43]      | Yanai et al., 2008         | Stress annealed FINEMET  |
| [47]      | Long et al., 2008          | Cut core FeCo HTX-002  |
| [30]      | Rylko et al., 2009         | MPP 26 Powder  |
| [44]      | Fukunaga et al., 2002      | Stress annealed FINEMET  |
| [50] 1    | Yoshida et al., 2000       | Amorphous Fe <sub>70</sub> Al <sub>5</sub> Ga <sub>2</sub> P <sub>9.65</sub> C <sub>5.75</sub> B <sub>4.6</sub> Si <sub>3</sub> Powder     |
| [50] 2    | Yoshida et al., 2000       | Mo-Permalloy Powder  |
| [51] 1    | Endo et al., 2000          | Mn-Zn Ferrite  |
| [51] 2    | Endo et al., 2000          | (Fe <sub>0.97</sub> Cr <sub>0.03</sub> ) <sub>76</sub> (Si <sub>0.5</sub> B <sub>0.5</sub> ) <sub>22</sub> C <sub>2</sub> Amorphous powder |
| [51] 3    | Endo et al., 2000          | Sendust  |
| [45]      | Yoshizawa et al., 2003     | Field annealed Fe <sub>8.8</sub> Co <sub>70</sub> Cu <sub>0.6</sub> Nb <sub>2.6</sub> Si <sub>9</sub> B <sub>9</sub> nanocomposite         |
| [52]      | Kolano-Burian et al., 2008 | Field annealed Fe <sub>14.7</sub> Co <sub>58.8</sub> Cu <sub>1</sub> Nb <sub>3</sub> Si <sub>13.5</sub> B <sub>9</sub> nanocomposite       |
| [53]      | Martis et al., 1994        | METGLAS 2705M  |

Materials Performance for High Power and High Frequency Inductor Applications Can Be Compared Through a “Power Ratio” Defined as Noted Above.

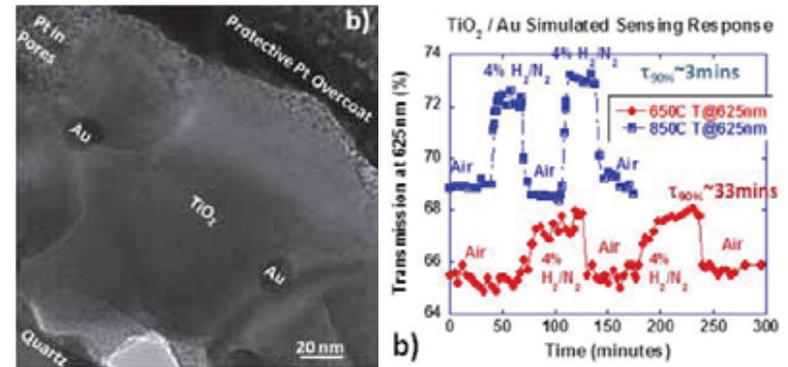
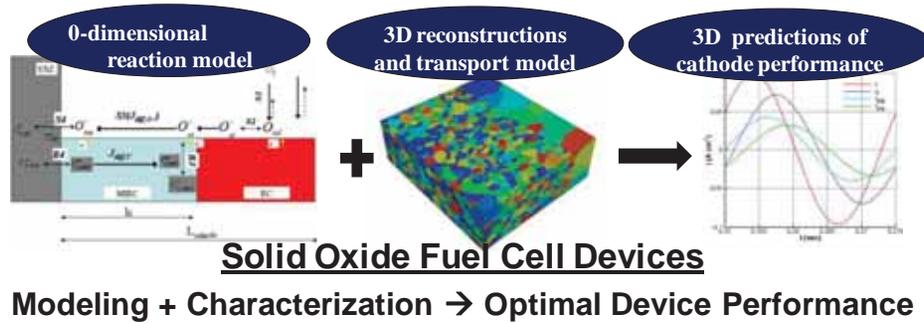
The “Power Ratio” Does Not Include Considerations of Parasitics, EMI, and Harmonics Important for WBG Power Electronics Which Must Be Measured at a “System” and/or “Component” Level.

# **Soft Magnetic Material and Device Research of NETL and Collaborators**

# NETL Electrochemical and Magnetic Material Team

Current Fiscal Year 2015

Current Fiscal Year 2015



## Solid Oxide Fuel Cell Materials

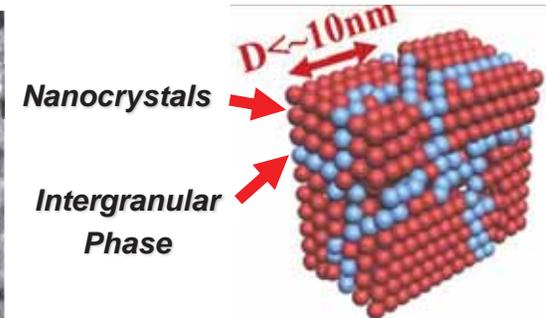
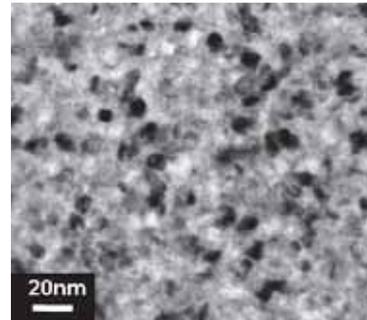
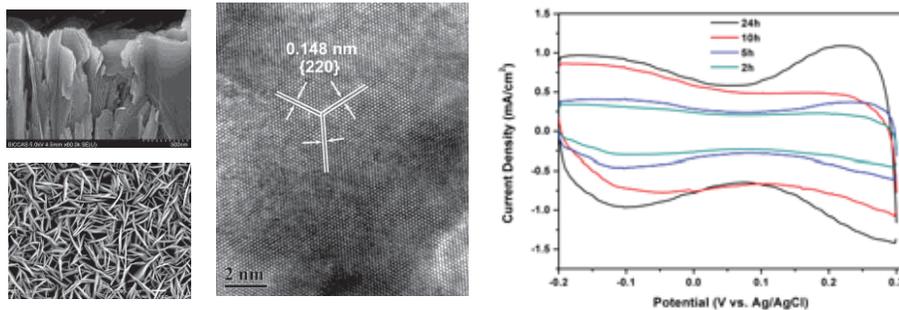
Function and Durability  
(DOE FE SECA Program)

## Sensor Materials

Chemical and Temperature Sensing  
(DOE FE Cross-Cutting Program, Others)

Ended Fiscal Year 2014

Current Fiscal Year 2015



## Energy Storage Materials

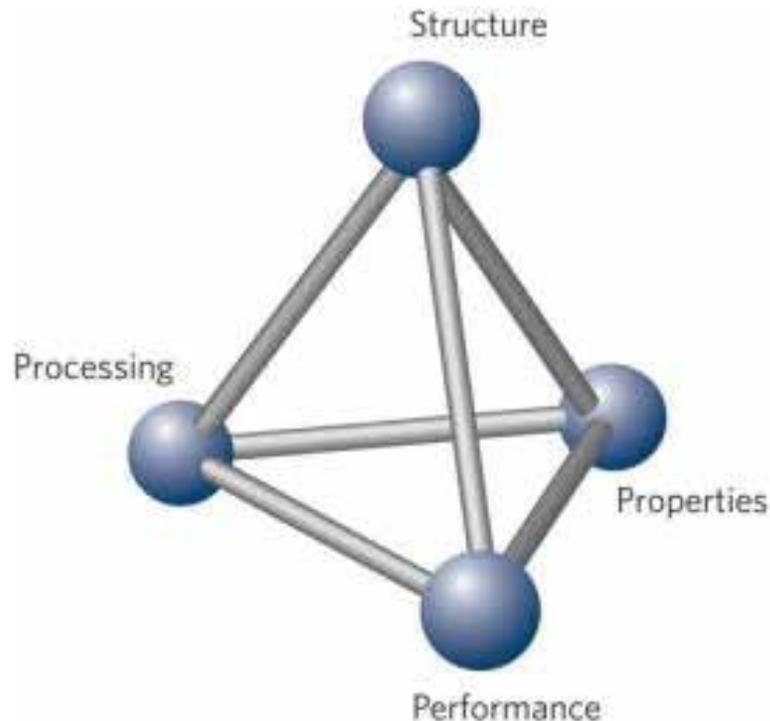
(DOE EERE Program)

## Soft Magnetic Materials

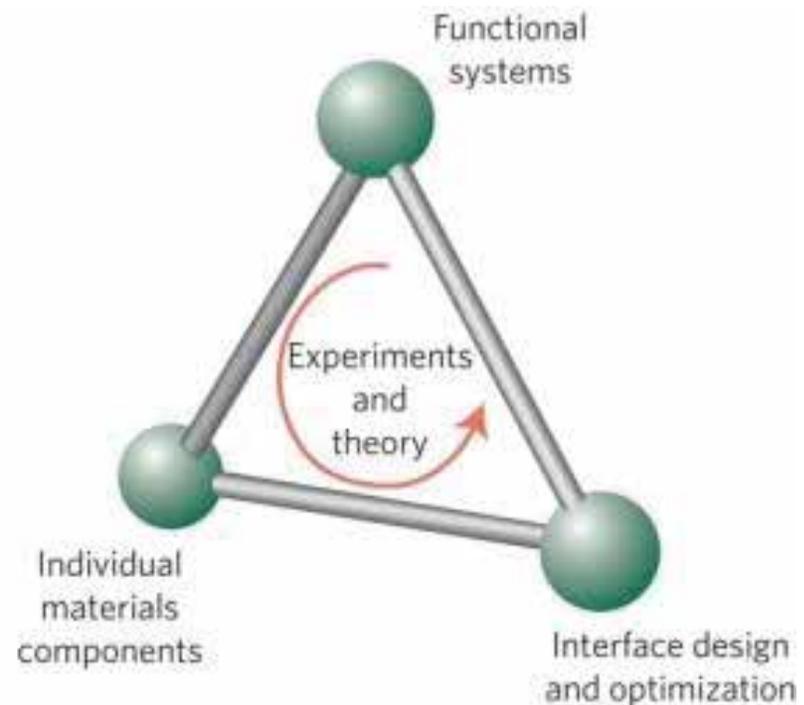
Inductors and Sensors  
(ARPA-E, URS, Others)

# Materials and Device Development Emphasis

## Classic Materials Science Paradigm



## Emerging Paradigm Materials Interface with Functional Systems and Devices



**Systems-Level Issues, Passives, and Peripherals Have Not Experienced the Same Level of Sustained Funding Support as WBG Switching Devices.**

**Major Opportunities and Needs for New Materials Innovations!**

# Rapid Solidification and Processing of Materials and Cores

Rapid Solidification Processing Enables Synthesis of Large-Scale Advanced Soft Magnetic Alloys to Enable High Power Device Fabrication



**NETL, Carnegie Mellon University, and Nearby NASA Glenn Research Center Collectively Have Close Collaborations and Unique Expertise and Facilities for Alloy Development and Processing, Large-Scale Casting, and Core Fabrication.**

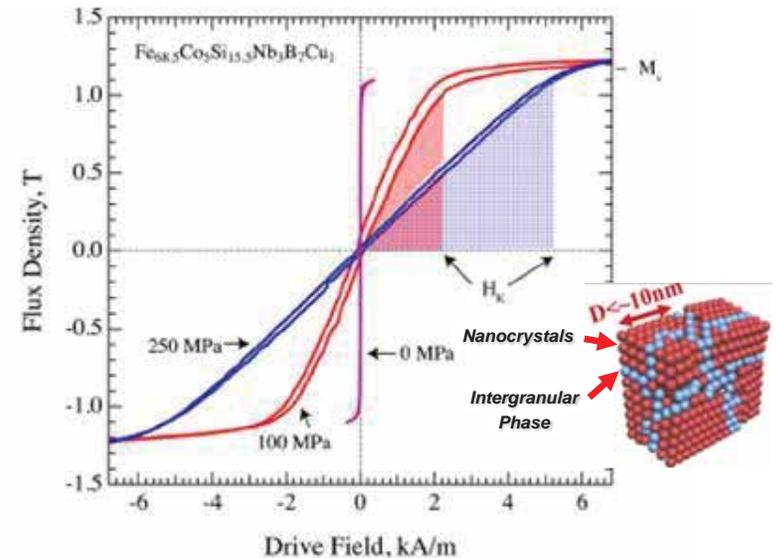
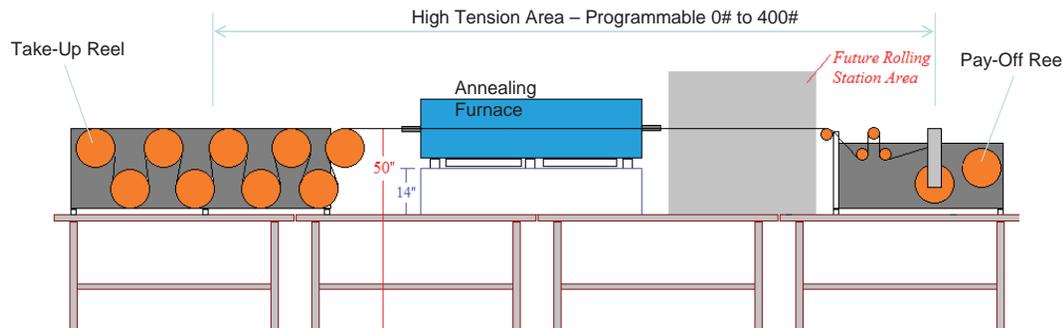
# Processing of Alloys to Optimize Permeability / Losses



Alloy / Ribbon Processing

Thermal  
Thermal + Magnetic  
Thermal + Mechanical  
e.g. Field or Stress Annealing

Commercial Scale Processing / Core Fabrication Facilities



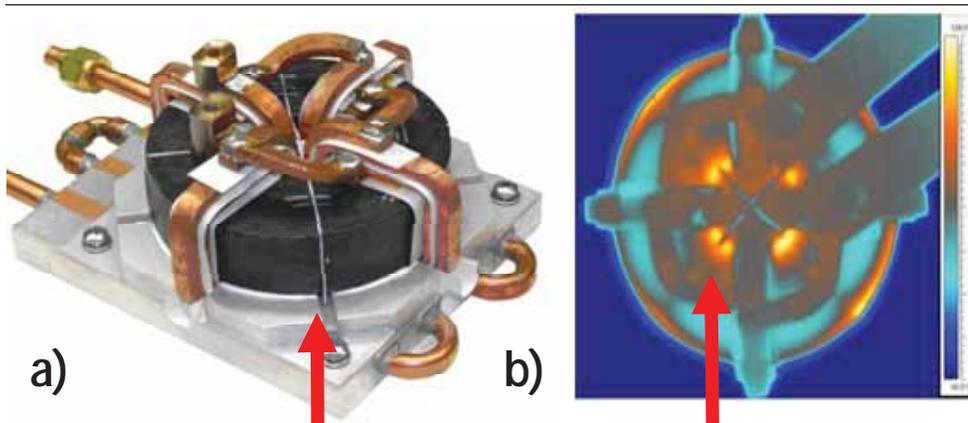
In Addition to Alloy Composition Design, Thermal Processing to Optimize Microstructure and Properties is Crucial and an Area of Major Emphasis.

“Tunable Permeabilities” of Alloy Compositions for a Particular Targeted Level Allows for Core and Alloy Optimization While Mitigating Against Parasitics, Stray Fields, and Fringing Fluxes at the Systems Level.

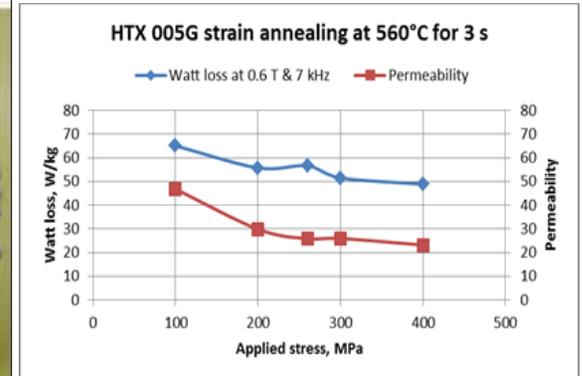
# Tunable Permeability Application : Ungapped Cores

CMU / NETL Joint Patent Filed on Strain Annealed Inductor Cores

Tunable Permeability by Strain Annealing Allows for Gap Elimination



Core Cutting and “Gapping” or Fabrication of a “Powder Core” to Make a Device Introduces Losses



Strain Annealing Can Avoid this Processing Step and Eliminate “Fringing Fluxes” / Parasitics

[Patent Application Filed](#)

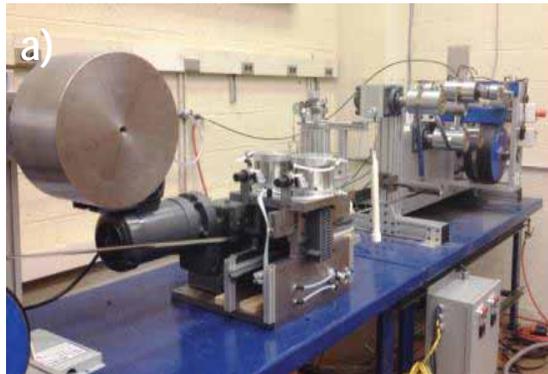
A Combination of Advanced Processing, Novel Alloy Compositions, and Core Fabrication Can Enable Completely New Solutions From the Perspective of Converter and Component Designs.

# Vertical Integration of Material, Core, Converter Development

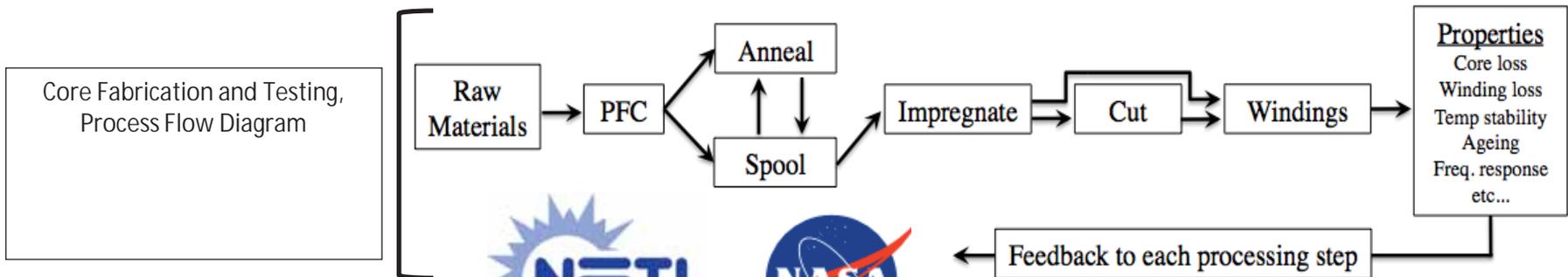
**In-Line Ribbon Processing**

**Large Number of Alloy Compositions “On-Hand”**

**Broad Array of Final Properties are Attainable**



| Alloy    | Remarks         | B <sub>m</sub> , T | μ           | P0.2/20, W/kg | T <sub>max</sub> , °C |
|----------|-----------------|--------------------|-------------|---------------|-----------------------|
| HTX 002  | Nanocrystalline | 1.55               | 1500        | 4-6           | 250                   |
| HTX 005C | Amorphous       | 1.02               | 670         | 5             |                       |
|          | Nanocrystalline | 0.96               | 480         | 8             | 400                   |
| HTX 005F | Nanocrystalline | 0.89               | 220         | 6-8           |                       |
| HTX 007A | Amorphous       | 1.52               | 1k to 3k*   | 3-5           |                       |
| HTX 003D | Nanocrystalline | 1.20               | 9k to 18k*  | 1.5           |                       |
| 2605SA1  | Amorphous       | 1.56               | 1k to 5k*   | 10            | 155                   |
| HTX012B  | Nanocrystalline | 1.25               | 15k to 20k* | 2             | 125                   |



**Carnegie Mellon University**

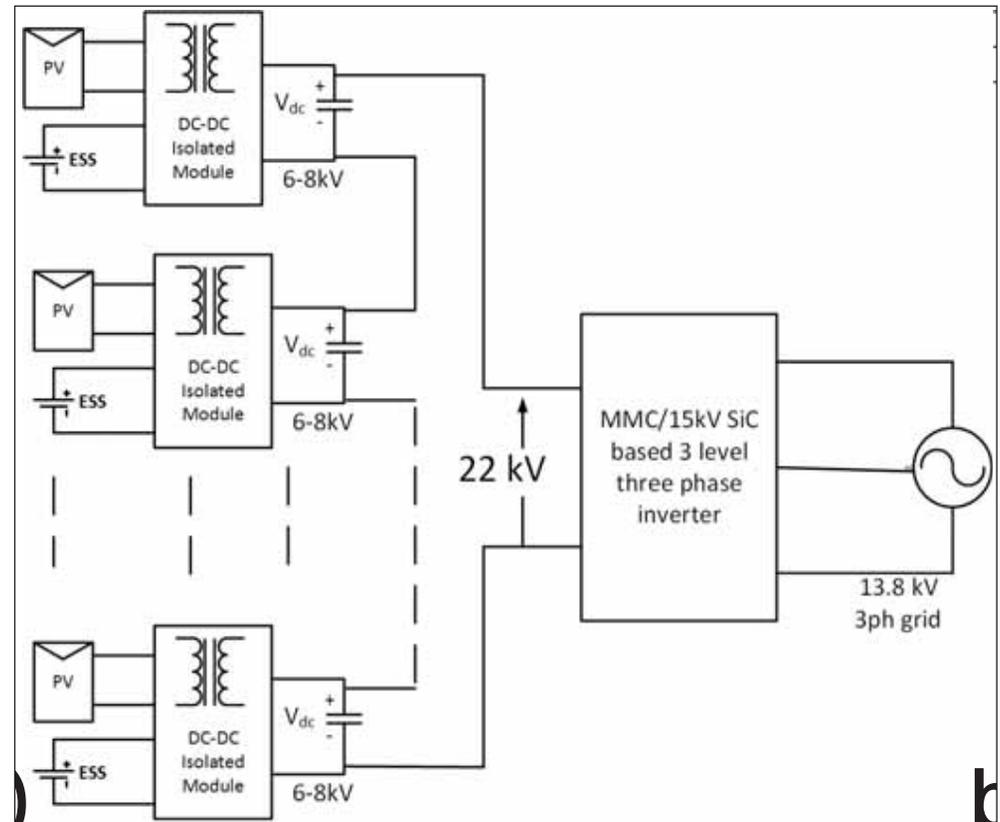
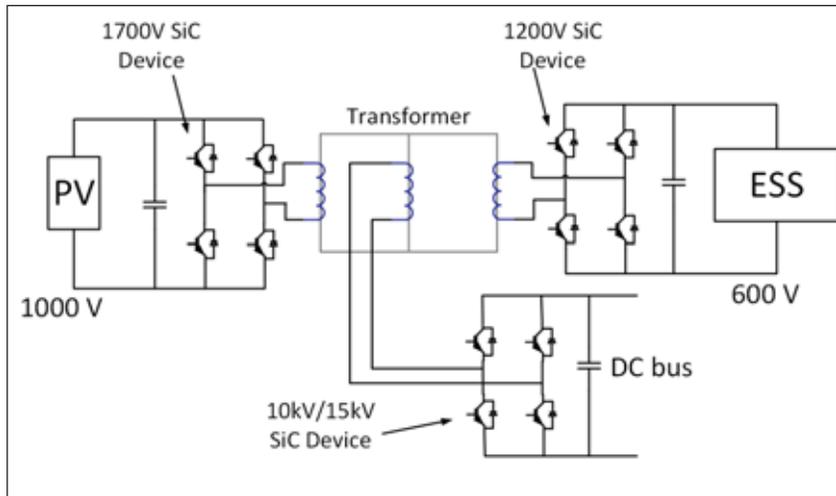


**Integrated Materials Development and Core Fabrication / Processing Activities Should Be Coupled with Converter Design and Development Activities to Ensure the Team Arrives at a “Global” Rather than a “Local Optimization”.**

**(Core Losses, Thermal Management, Parasitics, Inductance, Permeability)**

**NATIONAL ENERGY TECHNOLOGY LABORATORY**

# WBG Power Conversion Centered on HF Magnetics



Integration of Solar PV and Energy Storage Into an “Integrated Converter Module” Using a 3-Limb High Frequency Transformer and SiC Switching Devices Grid-Tied Through a DC Bus and a High Power Inverter.

High Frequency Transformers are Also a Foundational Technology for DC-DC and DC-AC Converters Utilized in Power Flow Control, Motor Drives, HVDC, etc.

# Advanced Transformer Design to Enable WBG PE Systems



Advances in the High Frequency  
Magnetics are Critical for Enabling the  
Integrated Converter Module Approach.



Alloy + Core Advances Required

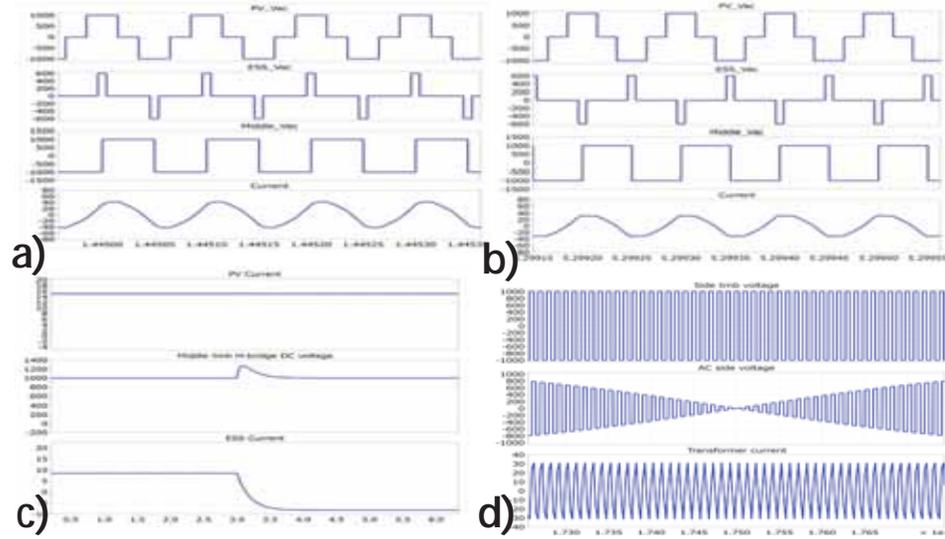


- Losses, Thermal Management, Parasitics

3-Limb  
High  
Frequency  
Transformer



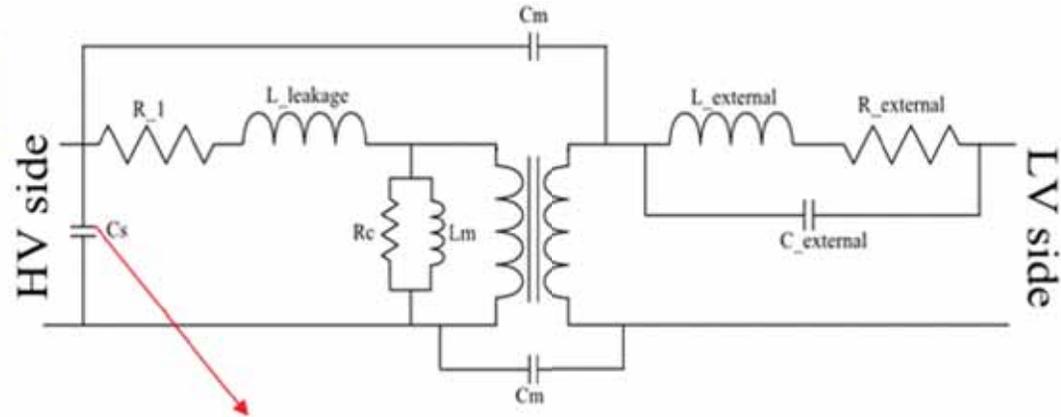
|                           |       |
|---------------------------|-------|
| Leakage Inductance        | 1.2mH |
| Magnetizing Inductance    | 15mH  |
| Self Capacitance          | 50nF  |
| Inter-Winding Capacitance | 100pF |



Advanced Transformer Design and Winding Principles are Coupled with  
Alloy Composition and Processing Research, Core Fabrication, and  
SiC Power Electronics Converter Designs to Address System Level Needs.

# Realistic Models of High Frequency Transformers

| High frequency Transformer<br>Parameter Value[Units] | 35kVA,22kV/800V<br>Measured parameters | 1MVA,16kV/2kV<br>Scaled parameters |
|--|--|------------------------------------|
| Total Equivalent self parastic Capacitance, $C_p$    | 50pF                                   | 52pF                               |
| Total Mutual Capacitance, $C_m$                      | 1200pF                                 | 208pF                              |
| Mag. Inductance, $L_m$                               | 293mH                                  | 640mH                              |
| Total Leakage from HV side                           | 643 $\mu$ H                            | 0.37mH                             |
| Equivalent core loss resitsance( $R_c$ )             | 6M $\Omega$                            | 1M $\Omega$                        |



| Transformer parasitic parameters |       |
|----------------------------------|-------|
| Self capacitance                 | 52pF  |
| Mutual capacitance               | 208pF |

- The parasitic capacitances cause spike current in the device which decides the current de-rating of the device
- The High speed SiC devices may cause high  $dv/dt$  across the transformer and hence spike current through the parasitic capacitances

| Parameters         | 15kV SiC IGBT device data | 10kV SiC MOSFET device data | 6.5kV Si IGBT device data |
|--------------------|---------------------------|-----------------------------|---------------------------|
| Rise time          | 500ns                     | 197ns                       | 350ns                     |
| falltime           | 1 $\mu$ s                 | 144ns                       | 3.8 $\mu$ s               |
| device capacitance | 0.01nF                    | 0.01nF                      | 0.001nF                   |
| stray inductance   | 5.4nH                     | 5.4nH                       | 5.4nH                     |

| Parameters       | JBS diode (SiC) device data | Si -diode device data |
|------------------|-----------------------------|-----------------------|
| reverse recovery | 350ns                       | 3.4 $\mu$ s           |
| $Q_{rr}$         | 0.79 $\mu$ C                | 370 $\mu$ C           |
| stray inductance | 5.4nH                       | 5.4nH                 |

**Parasitics Must Be Addressed for Successful Application of HF Transformers. Geometry, Windings, Insulation, Core Material and Processing All Play a Role Requiring an Interdisciplinary Team.**

# Summary and Conclusions

## Key Message #1:

- WBG Switching Devices are Beginning to Reach Maturity and Commercialization Due in Part to Long-Term Sustained Government Investment
- Systems Level Issues Will Increasingly Limit Widespread Deployment
  - Parasitics, Harmonics, and EMI
  - Thermal Management
  - Passive Components (HF Magnetics, HT Capacitors)
- Materials R&D Can Significantly Impact Systems-Level Concerns Just as it Has for the WBG Switching Devices
- No Program in DOE Currently Provides Sustaining R&D Support Focused Primarily on Passives and Other Systems Level Issues at T&D Scale for WBG Power Electronics

## Key Message #2:

- A Need Exists for Sustained DOE Support in Soft Magnetic Material Development, Manufacturing, and Device Integration (Transformers, Inductors, Motors)
- No US-Based / US Owned “CREE” of Soft Magnetic Alloys Exists Requiring Teaming Arrangements to Produce “Vertical Integration” for Optimized Materials R&D
- Coupled Magnetic Materials and Device Development is Needed for Enabling HF and HV WBG Power Electronics Converters and Topologies
- High Frequency Transformers / Filter Inductors are at the “Core” of Renewable Integration, Power Flow Controllers, HVDC Converters, Solid State Transformers, etc.

**Thank You to ORNL and DOE OE for the  
Opportunity to Attend and Present!**

**Please Contact Me if Interested in Discussing Potential Collaborations, Technical Support to Program Planning, or Further Details Regarding this Presentation.**

**Dr. Paul Ohodnicki, 412-386-7389, [paul.ohodnicki@netl.doe.gov](mailto:paul.ohodnicki@netl.doe.gov)**